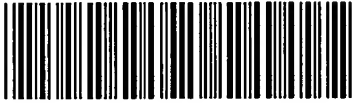


**Search Notes**

Application/Control No.

10/023,069

Examiner

Richard Lee

Applicant(s)/Patent under  
Reexamination

YAN ET AL.

Art Unit

2613

**SEARCHED**

Class	Subclass	Date	Examiner
Updated	Search	5/16/2005	RL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR